

WPM3407

Single P-Channel, -30 V, -4.4A, Power MOSFET

Description

The WPM3407 uses advanced trench technology to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in DC-DC conversion applications. Standard Product WPM3407 is Pb-free.

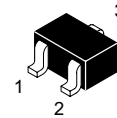
Features

$V_{(BR)DSS}$	$R_{DS(on)}$ Typ
-30 V	36 m Ω @ -10 V
	53 m Ω @ -4.5 V

Application

- Power Management in Note book
- Portable Equipment
- Battery Powered System
- DC/DC Converter
- Load Switch

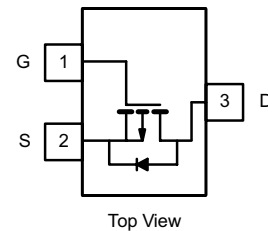
ABSOLUTE MAXIMUM RATINGS $T_A = 25^\circ\text{C}$, unless otherwise noted					
Parameter	Symbol	10 S	Steady State	Unit	
Drain-Source Voltage	V_{DS}	-30		V	
Gate-Source Voltage	V_{GS}	± 20			
Continuous Drain Current ($T_J = 150^\circ\text{C}$) ^a	$T_A = 25^\circ\text{C}$	I_D	-4.4	-3.7	A
	$T_A = 70^\circ\text{C}$		-3.5	-2.9	
Pulsed Drain Current	I_{DM}	-20			
Maximum Power Dissipation ^a	$T_A = 25^\circ\text{C}$	P_D	1.4	1.0	W
	$T_A = 70^\circ\text{C}$		0.9	0.6	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 150		$^\circ\text{C}$	



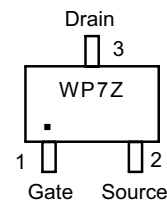
SOT 23-3

pin connections :

P-Channel



Marking:



W P7= Specific Device Code
Z = Date Code

Order information

Part Number	Package	Shipping
WPM3407-3/TR	SOT23-3	3000Tape&Reel



WPM3407

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance ^a	t ≤ 10 s	R _{θJA}	70	90	°C/W
	Steady State		90	125	
Junction-to-Case Thermal Resistance	Steady State	R _{θJC}	50	80	

a. Surface Mounted on FR4 Board using 1 in sq pad size, 1oz Cu.

Electrical Characteristics (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static Parameters						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0 V, I _D = -250 μA	-30			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 2.4 V, V _{GS} = 0 V	T _J = 25°C		-1	μA
			T _J = 85°C		-10	
Gate-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{GS} = V _{DS} , I _D = -250 μA	-1.0	-2.0	-3.0	V
Drain-source On-Resistance	R _{DS(on)}	V _{GS} = -10V, I _D = -4.4A		36	46	mΩ
		V _{GS} = -4.5, I _D = -3.0A		53	66	
Forward Recovery Voltage	V _{SD}	V _{GS} = 0 V, I _S = -1.0A	-0.5	-0.79	-1.5	V
Forward Transconductance	g _{FS}	V _{DS} = -5.0 V, I _D = -5 A	5	8		S
Dynamic						
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = -15 V	700	950	1200	pF
Output Capacitance	C _{oss}		90	120	150	
Reverse Transfer Capacitance	C _{rss}		75	100	125	
Total Gate Charge	Q _{g(tot)}	V _{GS} = -10 V, V _{DS} = -15 V, I _D = -5 A	13	18	23	nC
Threshold Gate Charge	Q _{g(th)}		1.5	2	2.5	
Gate- Source Charge	Q _{gs}		2	2.5	3	
Gate- Drain Charge	Q _{gd}		3	3.8	4.5	
Gate Resistance	R _g	V _{GS} = 0 V, V _{DS} = 0 V, f = 1.0 MHz		5	8	Ω
Switching Parameters						
Turn-On Delay Time	t _{d(on)}	V _{GS} = -10 V, V _{DS} = -15 V, I _D = -4.3A, R _G = 6 Ω	8	11	15	ns
Rise Time	t _r		4	6	9	
Turn-Off Delay Time	t _{d(off)}		30	40	50	
Fall Time	t _f		5	7.5	10	
Body Diode Reverse Recovery Time	t _{rr}	I _F = -5A, dI/dt = 100A/μs		25		ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = -5A, dI/dt = 100A/μs		14		nC